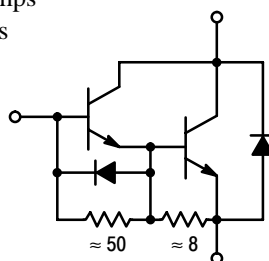


# SWITCHMODE™ Series

## NPN Silicon Power Darlington Transistors with Base-Emitter Speedup Diode

The MJ10015 and MJ10016 Darlington transistors are designed for high-voltage, high-speed, power switching in inductive circuits where fall time is critical. They are particularly suited for line-operated SWITCHMODE applications such as:

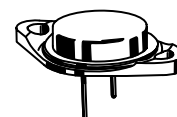
- Switching Regulators
- Motor Controls
- Inverters
- Solenoid and Relay Drivers
- Fast Turn-Off Times
  - 1.0  $\mu$ s (max) Inductive Crossover Time — 20 Amps
  - 2.5  $\mu$ s (max) inductive Storage Time — 20 Amps
- Operating Temperature Range –65 to +200°C
- Performance Specified for
  - Reversed Biased SOA with Inductive Load
  - Switching Times with Inductive Loads
  - Saturation Voltages
  - Leakage Currents



# MJ10015

# MJ10016

50 AMPERE  
NPN SILICON  
POWER DARLINGTON  
TRANSISTORS  
400 AND 500 VOLTS  
250 WATTS



CASE 197-05  
TO-204AE TYPE  
(TO-3 TYPE)

### MAXIMUM RATINGS

Rating	Symbol	MJ10015	MJ10016	Unit
Collector-Emitter Voltage	$V_{CEO}$	400	500	Vdc
Collector-Emitter Voltage	$V_{CEV}$	600	700	Vdc
Emitter Base Voltage	$V_{EB}$	8.0		Vdc
Collector Current — Continuous	$I_C$	50		Adc
— Peak (1)	$I_{CM}$	75		
Base Current — Continuous	$I_B$	10		Adc
— Peak (1)	$I_{BM}$	15		
Total Power Dissipation @ $T_C = 25^\circ\text{C}$	$P_D$	250		Watts
@ $T_C = 100^\circ\text{C}$		143		
Derate above 25°C		1.43		W/°C
Operating and Storage Junction Temperature Range	$T_J, T_{stg}$	–65 to +200		°C

### THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$	0.7	°C/W
Maximum Lead Temperature for Soldering Purposes: 1/8" from Case for 5 Seconds	$T_L$	275	°C

(1) Pulse Test: Pulse Width = 5 ms, Duty Cycle  $\leq$  10%.

# MJ10015 MJ10016

## ELECTRICAL CHARACTERISTICS ( $T_C = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
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### OFF CHARACTERISTICS (1)

Collector–Emitter Sustaining Voltage (Table 1) ( $I_C = 100\text{ mA}$ , $I_B = 0$ , $V_{\text{clamp}} = \text{Rated } V_{\text{CEO}}$ )	MJ10015 MJ10016	$V_{\text{CEO(sus)}}$	400 500	— —	— —	Vdc
Collector Cutoff Current ( $V_{\text{CEV}} = \text{Rated Value}$ , $V_{\text{BE(off)}} = 1.5\text{ Vdc}$ )		$I_{\text{CEV}}$	—	—	0.25	mAdc
Emitter Cutoff Current ( $V_{\text{EB}} = 2.0\text{ Vdc}$ , $I_C = 0$ )		$I_{\text{EBO}}$	—	—	350	mAdc

### SECOND BREAKDOWN

Second Breakdown Collector Current with Base Forward Biased	$I_{\text{S/b}}$	See Figure 7	
Clamped Inductive SOA with Base Reverse Biased	RBSOA	See Figure 8	

### ON CHARACTERISTICS (1)

DC Current Gain ( $I_C = 20\text{ Adc}$ , $V_{\text{CE}} = 5.0\text{ Vdc}$ ) ( $I_C = 40\text{ Adc}$ , $V_{\text{CE}} = 5.0\text{ Vdc}$ )	$h_{\text{FE}}$	25 10	— —	— —	—
Collector–Emitter Saturation Voltage ( $I_C = 20\text{ Adc}$ , $I_B = 1.0\text{ Adc}$ ) ( $I_C = 50\text{ Adc}$ , $I_B = 10\text{ Adc}$ )	$V_{\text{CE(sat)}}$	— —	— —	2.2 5.0	Vdc
Base–Emitter Saturation Voltage ( $I_C = 20\text{ Adc}$ , $I_B = 1.0\text{ Adc}$ )	$V_{\text{BE(sat)}}$	—	—	2.75	Vdc
Diode Forward Voltage (2) ( $I_F = 20\text{ Adc}$ )	$V_f$	—	2.5	5.0	Vdc

### DYNAMIC CHARACTERISTIC

Output Capacitance ( $V_{\text{CB}} = 10\text{ Vdc}$ , $I_E = 0$ , $f_{\text{test}} = 100\text{ kHz}$ )	$C_{\text{ob}}$	—	—	750	pF
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### SWITCHING CHARACTERISTICS

Resistive Load (Table 1)						
Delay Time	$(V_{CC} = 250\text{ Vdc}, I_C = 20\text{ A},$ $I_{B1} = 1.0\text{ Adc}, V_{BE(off)} = 5\text{ Vdc}, t_p = 25\text{ }\mu\text{s}$ Duty Cycle $\leq 2\%$ ).	$t_d$	—	0.14	0.3	$\mu\text{s}$
Rise Time		$t_r$	—	0.3	1.0	$\mu\text{s}$
Storage Time		$t_s$	—	0.8	2.5	$\mu\text{s}$
Fall Time		$t_f$	—	0.3	1.0	$\mu\text{s}$
Inductive Load, Clamped (Table 1)						
Storage Time	$(I_C = 20\text{ A(pk)}, V_{\text{clamp}} = 250\text{ V}, I_{B1} = 1.0\text{ A},$ $V_{BE(off)} = 5.0\text{ Vdc})$	$t_{sv}$	—	1.0	2.5	$\mu\text{s}$
Crossover Time		$t_c$	—	0.36	1.0	$\mu\text{s}$

(1) Pulse Test: Pulse Width = 300  $\mu\text{s}$ , Duty Cycle  $\leq 2\%$ .

(2) The internal Collector–to–Emitter diode can eliminate the need for an external diode to clamp inductive loads.

Tests have shown that the Forward Recovery Voltage ( $V_f$ ) of this diode is comparable to that of typical fast recovery rectifiers.

TYPICAL CHARACTERISTICS

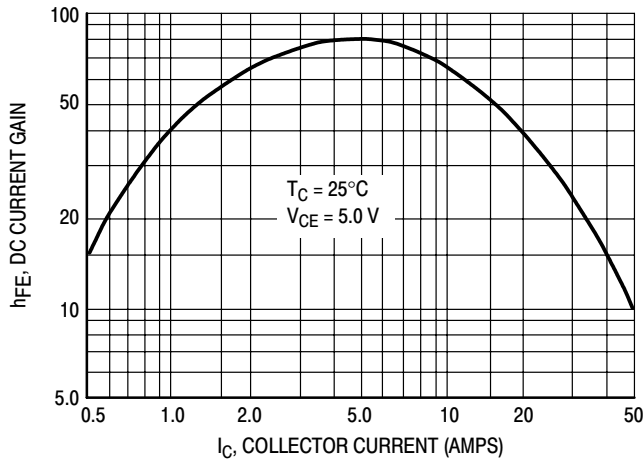


Figure 1. DC Current Gain

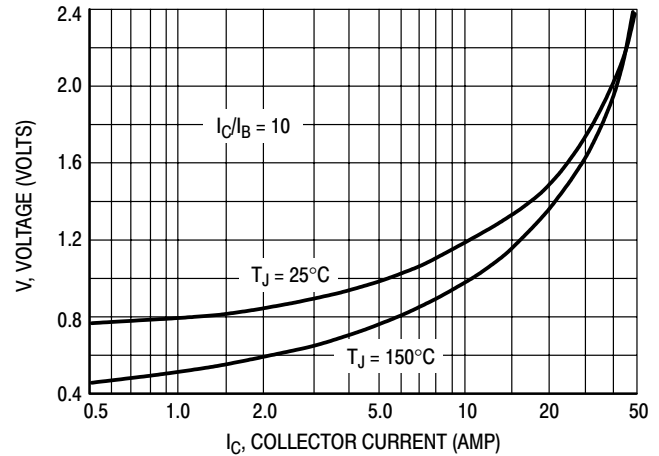


Figure 2. Collector-Emitter Saturation Voltage

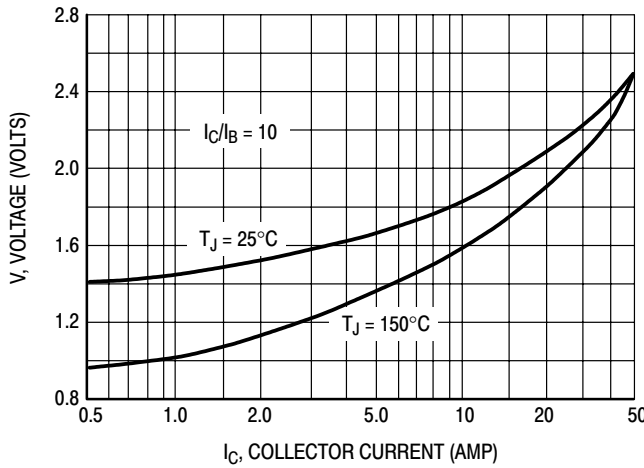


Figure 3. Base-Emitter Saturation Voltage

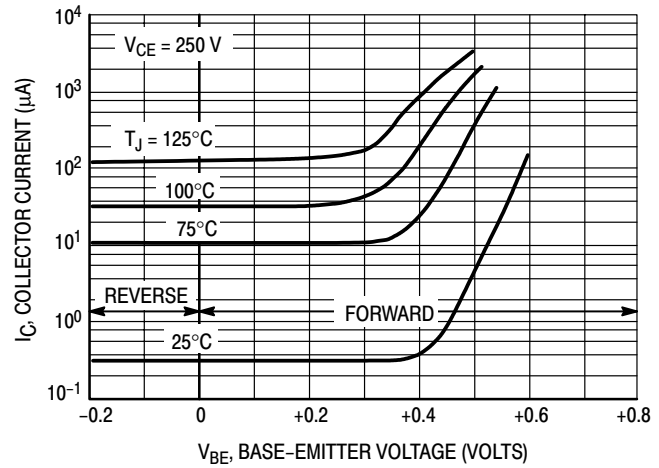


Figure 4. Collector Cutoff Region

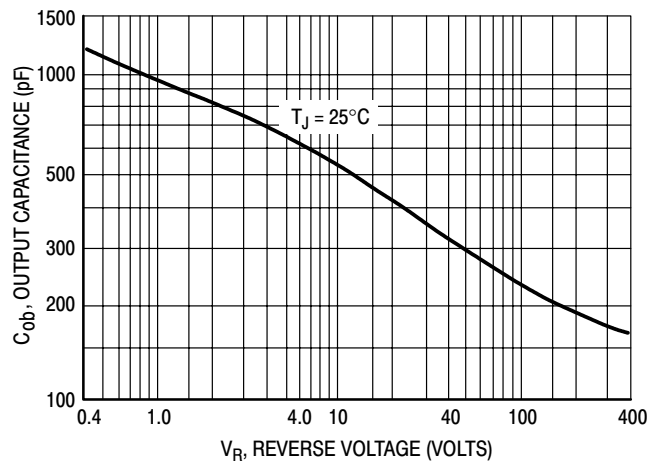
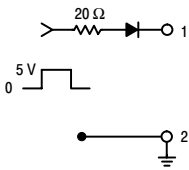
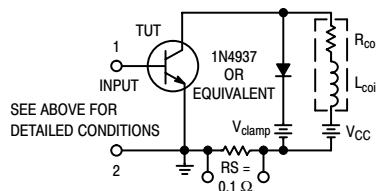
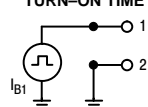
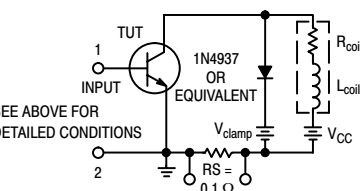
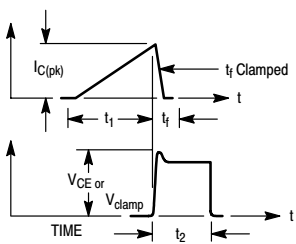
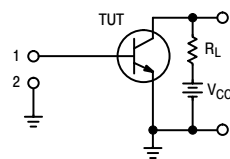


Figure 5. Output Capacitance

Table 1. Test Conditions for Dynamic Performance

	$V_{CEO(sus)}$	$V_{CEX}$ AND INDUCTIVE SWITCHING	RESISTIVE SWITCHING
INPUT CONDITIONS	 <p>PW Varied to Attain <math>I_C = 100 \text{ mA}</math></p>	<p>INDUCTIVE TEST CIRCUIT</p>  <p>SEE ABOVE FOR DETAILED CONDITIONS</p>	<p>TURN-ON TIME</p>  <p><math>I_{B1}</math> adjusted to obtain the forced <math>h_{FE}</math> desired</p> <p>TURN-OFF TIME</p> <p>Use inductive switching driver as the input to the resistive test circuit.</p>
CIRCUIT VALUES	$L_{coil} = 10 \text{ mH}$ , $V_{CC} = 10 \text{ V}$ $R_{coil} = 0.7 \Omega$ $V_{clamp} = V_{CEO(sus)}$	$L_{coil} = 180 \mu\text{H}$ $R_{coil} = 0.05 \Omega$ $V_{CC} = 20 \text{ V}$	$V_{CC} = 250 \text{ V}$ $R_L = 12.5 \Omega$ Pulse Width = $25 \mu\text{s}$
TEST CIRCUITS	<p>INDUCTIVE TEST CIRCUIT</p>  <p>SEE ABOVE FOR DETAILED CONDITIONS</p>	<p>OUTPUT WAVEFORMS</p>  <p> <math>t_1</math> Adjusted to Obtain <math>I_C</math>  <math>t_1 = \frac{L_{coil} (I_{Cpk})}{V_{CC}}</math>  <math>t_2 = \frac{L_{coil} (I_{Cpk})}{V_{Clamp}}</math>  Test Equipment Scope — Tektronix 475 or Equivalent </p>	<p>RESISTIVE TEST CIRCUIT</p> 

\*Adjust  $-V$  such that  $V_{BE(off)} = 5 \text{ V}$  except as required for RBSOA (Figure 8).

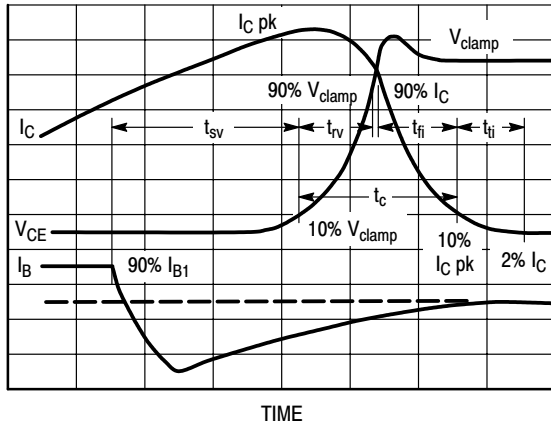


Figure 6. Inductive Switching Measurements

#### SWITCHING TIMES NOTE

In resistive switching circuits, rise, fall, and storage times have been defined and apply to both current and voltage waveforms since they are in phase. However, for inductive loads which are common to SWITCHMODE power supplies and hammer drivers, current and voltage

waveforms are not in phase. Therefore, separate measurements must be made on each waveform to determine the total switching time. For this reason, the following new terms have been defined.

$t_{sv}$  = Voltage Storage Time, 90%  $I_{B1}$  to 10%  $V_{clamp}$   
 $t_{rv}$  = Voltage Rise Time, 10–90%  $V_{clamp}$   
 $t_{fi}$  = Current Fall Time, 90–10%  $I_C$   
 $t_{ti}$  = Current Tail, 10–2%  $I_C$   
 $t_c$  = Crossover Time, 10%  $V_{clamp}$  to 10%  $I_C$

For the designer, there is minimal switching loss during storage time and the predominant switching power losses occur during the crossover interval and can be obtained using the standard equation from AN-222:

$$P_{SWT} = 1/2 V_{CC} I_C (t_c) f$$

In general,  $t_{rv} + t_{fi} \approx t_c$ . However, at lower test currents this relationship may not be valid.

As is common with most switching transistors, resistive switching is specified and has become a benchmark for designers. However, for designers of high frequency converter circuits, the user oriented specifications which make this a “SWITCHMODE” transistor are the inductive switching speeds ( $t_c$  and  $t_{sv}$ ) which are guaranteed.

The Safe Operating Area figures shown in Figures 7 and 8 are specified ratings for these devices under the test conditions shown.

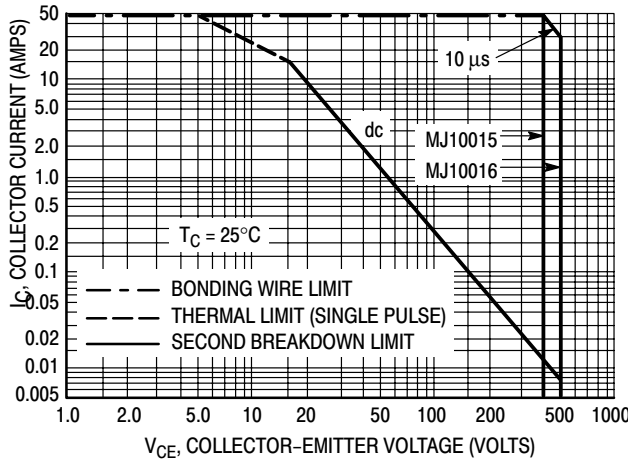


Figure 7. Forward Bias Safe Operating Area

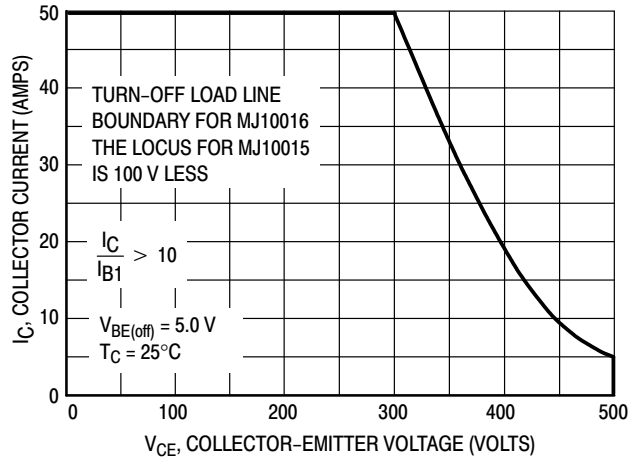


Figure 8. Reverse Bias Switching Safe Operating Area

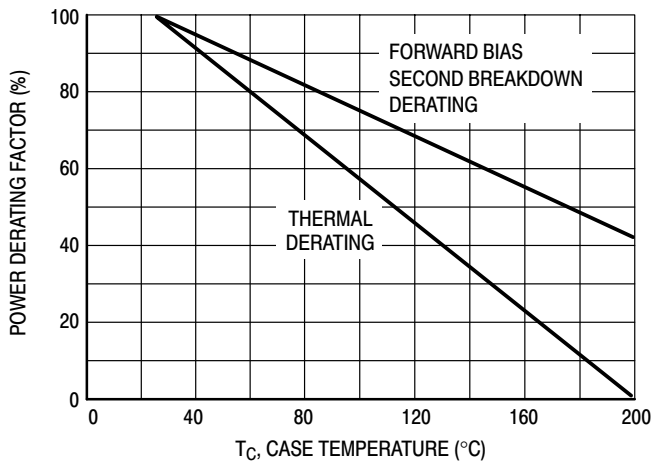


Figure 9. Power Derating

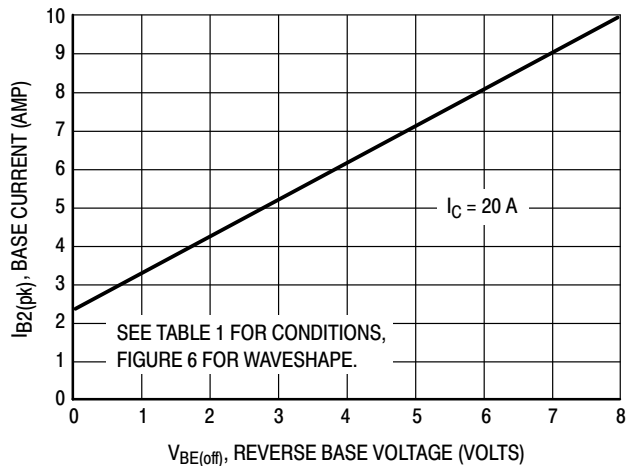


Figure 10. Typical Reverse Base Current versus  $V_{BE(off)}$  With No External Base Resistance

## SAFE OPERATING AREA INFORMATION

### FORWARD BIAS

There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate  $I_C - V_{CE}$  limits of the transistor that must be observed for reliable operation, i.e., the transistor must not be subjected to greater dissipation than the curves indicate.

The data of Figure 7 is based on  $T_C = 25^\circ\text{C}$ ;  $T_{J(pk)}$  is variable depending on power level. Second breakdown pulse limits are valid for duty cycles to 10% but must be derated when  $T_C \geq 25^\circ\text{C}$ . Second breakdown limitations do not derate the same as thermal limitations. Allowable current at the voltages shown on Figure 7 may be found at any case temperature by using the appropriate curve on Figure 9.

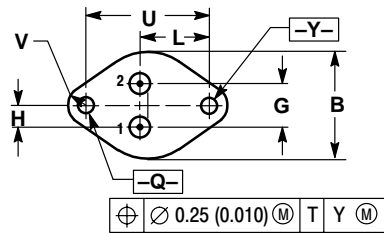
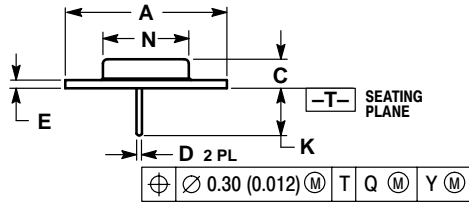
### REVERSE BIAS

For inductive loads, high voltage and high current must be sustained simultaneously during turn-off, in most cases, with the base to emitter junction reverse biased. Under these conditions the collector voltage must be held to a safe level at or below a specific value of collector current. This can be accomplished by several means such as active clamping, RC snubbing, load line shaping, etc. The safe level for these devices is specified as Reverse Bias Safe Operating Area and represents the voltage-current condition allowable during reverse biased turn-off. This rating is verified under clamped conditions so that the device is never subjected to an avalanche mode. Figure 8 gives the complete RBSOA characteristics.

# MJ10015 MJ10016

## PACKAGE DIMENSIONS

TO-204AE (TO-3)  
CASE 197A-05  
ISSUE J




- NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: INCH.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	1.530 REF		38.86 REF	
B	0.990	1.050	25.15	26.67
C	0.250	0.335	6.35	8.51
D	0.057	0.063	1.45	1.60
E	0.060	0.070	1.53	1.77
G	0.430 BSC		10.92 BSC	
H	0.215 BSC		5.46 BSC	
K	0.440	0.480	11.18	12.19
L	0.665 BSC		16.89 BSC	
N	0.760	0.830	19.31	21.08
Q	0.151	0.165	3.84	4.19
U	1.187 BSC		30.15 BSC	
V	0.131	0.188	3.33	4.77

## **Notes**

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